FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 36856.617	SERIAL NO. :	Currently unknown
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)			54921 54921 5702
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Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
Die	AA 5,906,950	05/1999	Keller et al.	438	7/9
1	AB 5,932,950	08/1999	Yamada et al.	310	2/13
	AC 6,185,801	02/2001	Kadota et al.	29	25.35
	AD 5,497,726	03/1996	Shikata et al.	110	89
-	AE 5,446,329	08/1995	Nakahata et al.	310	3/3
ال	AF 5,356,870	10/1994	Fujiwara et al.	605	329
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Du .	AG 2-189011 (With Abstracts)	07/1990	Japan		
11.	AH 5-299960 (With Abstracts)	11/1993	Japan		
1 /	AI 6-268463 (With Abstracts)	09/1994	Japan		
	AJ 6-188664 (With Abstracts)	07/1994	Japan		
	AK 6-120759 (With Abstracts)	04/1994	Japan		
,	AL 6-120416 (With Abstracts)	04/1994	Japan		
	AM 6-97760 (With Abstracts)	04/1994	Japan	.//>	
//	AN 6-6160 (With Abstracts)	01/1994	Japan		
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pe,	AP R. SUBRAMANIAN et al.; "Proc SAW Characteristics; 01/1996; IEEE			nemistry and its	Effects on
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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Eiichi TAKATA et al.	
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Initial	Document Number	Date	Name	Class	appropriate
	AA 5,343,107	08/1994	Shikata et al.	210	313
	AB 5,914,646	06/1999	Hashimoto	333	1.95
	AC 4,756,794	07/1988	Yoder	156	643
	AD 5,235,236	08/1993	Nakahata et al.	310	195 643 313
	AE 5,774,962	07/1998	Satoh et al.	29	25.35
	AF 4,403,165	09/1983	Ballato et al.	310	313
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FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 36856.617	SERIAL NO.: 10/054,921
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Eiichi TAKATA e COPY OF PAR ORIGINALLY F	AUG 2 0 2002
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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Eiichi TAKATA	et al. PECHNOLOGY CENT 2003
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7	Document Number	Date	Country	Class	appropriate
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